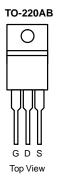
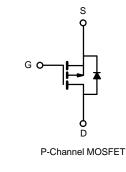


# P-Channel 60 V (D-S) MOSFET

| PRODUCT             | SUMMARY                            |                    |                       |
|---------------------|------------------------------------|--------------------|-----------------------|
| V <sub>DS</sub> (V) | R <sub>DS(on)</sub> (Ω) Max.       | I <sub>D</sub> (A) | Q <sub>g</sub> (Typ.) |
| - 60                | 0.0480 at V <sub>GS</sub> = - 10 V | - 45               | 67                    |
| - 30                | 0.0560 at V_{GS} = - 4.5 V         | - 40               | 07                    |





## **FEATURES**

- Halogen-free According to IEC 61249-2-21
  Definition
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>q</sub> and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

### **APPLICATIONS**

- Power Switch
- Load Switch in High Current Applications
- DC/DC Converters

| <b>ABSOLUTE MAXIMUM RATINGS</b>                      | (T <sub>C</sub> = 25 °C, unless oth | erwise noted)                     |                   |      |  |
|--|-------------------------------------|-----------------------------------|-------------------|------|--|
| Parameter  |                                     | Symbol                            | Limit             | Unit |  |
| Drain-Source Voltage                                 |                                     | V <sub>DS</sub>                   | - 60              | V    |  |
| Gate-Source Voltage                                  |                                     | V <sub>GS</sub>                   | ± 20              |      |  |
| Continuous Drain Current ( $T_1 = 150 \ ^{\circ}C$ ) | T <sub>C</sub> = 25 °C              | la la                             | - 45              | А    |  |
| Continuous Drain Current (1j = 150°C)                | T <sub>C</sub> = 70 °C              |                                   | - 39              |      |  |
| Pulsed Drain Current (t = 300 µs)                    |                                     | I <sub>DM</sub>                   | - 100             | A    |  |
| Avalanche Current                                    |                                     | I <sub>AS</sub>                   | - 32              |      |  |
| Single Avalanche Energy <sup>a</sup> L = 0.1 mH      |                                     | E <sub>AS</sub>                   | 51                | mJ   |  |
|  | T <sub>C</sub> = 25 °C              | Р                                 | 41.7 <sup>b</sup> | w    |  |
| Maximum Power Dissipation <sup>a</sup>               | T <sub>A</sub> = 25 °C <sup>c</sup> | – P <sub>D</sub> –                | 2.1               |      |  |
| Operating Junction and Storage Temperature Range     |                                     | T <sub>J</sub> , T <sub>stg</sub> | - 55 to 150       | °C   |  |

| THERMAL RESISTANCE RATINGS                   |                   |       |      |
|--|-------------------|-------|------|
| Parameter                                    | Symbol            | Limit | Unit |
| Junction-to-Ambient (PCB Mount) <sup>c</sup> | R <sub>thJA</sub> | 60    | °C/W |
| Junction-to-Case (Drain)                     | R <sub>thJC</sub> | 3     | C/W  |

Notes:

a. Duty cycle  $\leq$  1 %.

b. See SOA curve for voltage derating.

c. When mounted on 1" square PCB (FR-4 material).



| <b>SPECIFICATIONS</b> ( $T_J = 25$            | °C, unless o         | otherwise noted)  |       |       |       |      |
|---|----------------------|---|-------|-------|-------|------|
| Parameter                                     | Symbol               | Test Conditions   | Min.  | Тур.  | Max.  | Unit |
| Static  |                      | · · · ·   |       | •     |       |      |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>      | $V_{DS} = 0 V, I_{D} = -250 \mu A$                                      | - 60  |       |       | V    |
| Gate Threshold Voltage                        | V <sub>GS(th)</sub>  | $V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$                                 | - 1.0 |       | - 3.0 | v    |
| Gate-Body Leakage                             | I <sub>GSS</sub>     | $V_{DS} = 0 V, V_{GS} = \pm 20 V$                                       |       |       | ± 250 | nA   |
|   |                      | $V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$                  |       |       | - 1   |      |
| Zero Gate Voltage Drain Current               | I <sub>DSS</sub>     | $V_{DS} = -60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 \text{ °C}$  |       |       | - 50  | μA   |
|   |                      | $V_{DS} = -60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 150 \text{ °C}$  |       |       | - 250 |      |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>   | $V_{DS} \le$ - 10 V, $V_{GS}$ = - 10 V                                  | - 30  |       |       | А    |
|   | P                    | V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 14 A                       |       | 0.048 |       | Ω    |
| Drain-Source On-State Resistance <sup>a</sup> | R <sub>DS(on)</sub>  | V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 12 A                      |       | 0.056 |       | 52   |
| Forward Transconductance <sup>a</sup>         | 9 <sub>fs</sub>      | V <sub>DS</sub> = - 20 V, I <sub>D</sub> = - 14 A                       |       | 40    |       | S    |
| Dynamic <sup>b</sup>                          |                      |   |       |       |       |      |
| Input Capacitance                             | C <sub>iss</sub>     |   |       | 2065  |       | pF   |
| Output Capacitance                            | C <sub>oss</sub>     | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = - 30 V, f = 1 MHz              |       | 330   |       |      |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>     |   |       | 280   |       |      |
| Total Gate Charge <sup>c</sup>                | Qg                   |   |       | 67    | 100   |      |
| Gate-Source Charge <sup>c</sup>               | Q <sub>gs</sub>      | $V_{DS} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -14 \text{ A}$ |       | 13.5  |       | nC   |
| Gate-Drain Charge <sup>c</sup>                | Q <sub>gd</sub>      |   |       | 14    |       | 1    |
| Gate Resistance                               | Rg                   | f = 1 MHz   | 0.5   | 2.5   | 5     | Ω    |
| Turn-On Delay Time <sup>c</sup>               | t <sub>d(on)</sub>   |   |       | 10    | 20    |      |
| Rise Time <sup>c</sup>                        | t <sub>r</sub>       | $V_{DD}$ = - 30 V, R <sub>L</sub> = 2 $\Omega$                          |       | 11    | 20    | 1    |
| Turn-Off Delay Time <sup>c</sup>              | t <sub>d(off)</sub>  | $I_D \cong$ - 10 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$              |       | 42    | 63    | ns   |
| Fall Time <sup>c</sup>                        | t <sub>f</sub>       |   |       | 12    | 20    |      |
| Drain-Source Body Diode Ratings and           | nd Characteri        | stics T <sub>C</sub> = 25 °C <sup>b</sup>                               |       |       |       |      |
| Continuous Current                            | ۱ <sub>S</sub>       |   |       |       | - 40  | ٨    |
| Pulsed Current                                | I <sub>SM</sub>      |   |       |       | - 100 | A    |
| Forward Voltage <sup>a</sup>                  | V <sub>SD</sub>      | I <sub>F</sub> = - 10 A, V <sub>GS</sub> = 0 V                          |       | - 0.8 | - 1.5 | V    |
| Reverse Recovery Time                         | t <sub>rr</sub>      |   |       | 38    | 57    | ns   |
| Peak Reverse Recovery Current                 | I <sub>RM(REC)</sub> | I <sub>F</sub> = - 10 A, dl/dt = 100 A/μs                               |       | 2.3   | 3.5   | А    |
| Reverse Recovery Charge                       | Q <sub>rr</sub>      | 1   |       | 40    | 60    | nC   |

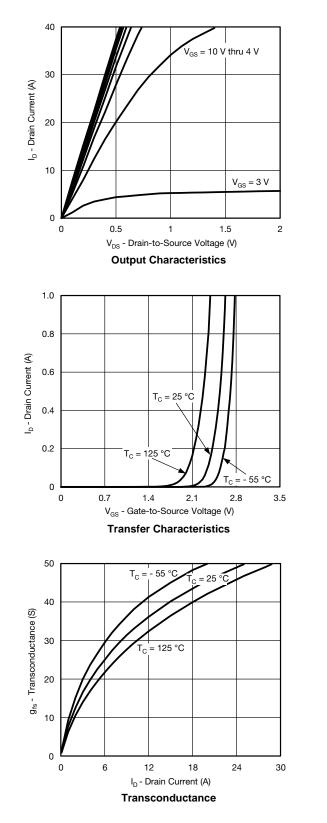
Notes:

a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.

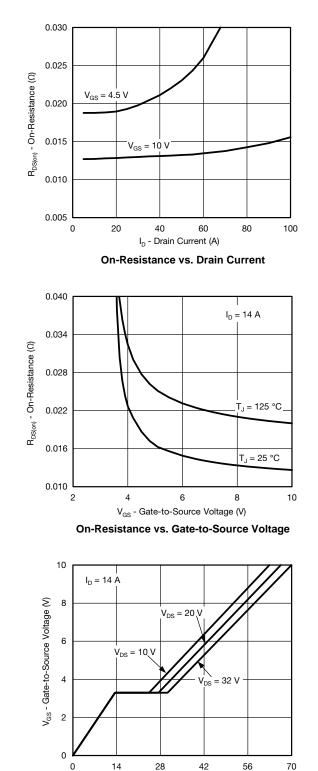
c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





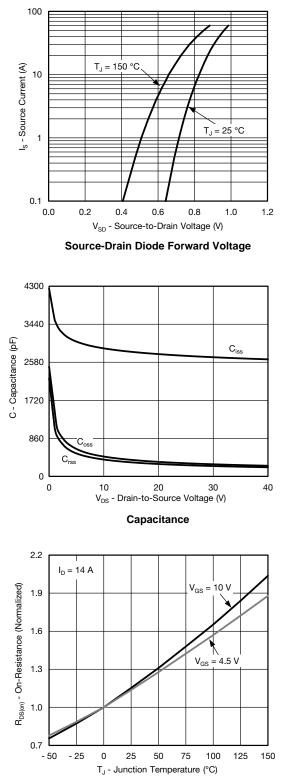
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



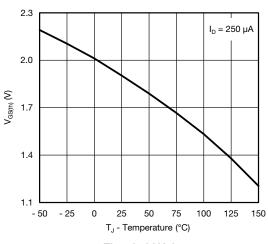
Q<sub>g</sub> - Total Gate Charge (nC) Gate Charge



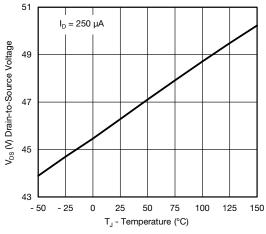




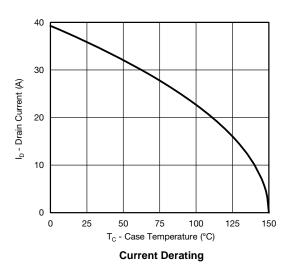
**On-Resistance vs. Junction Temperature** 



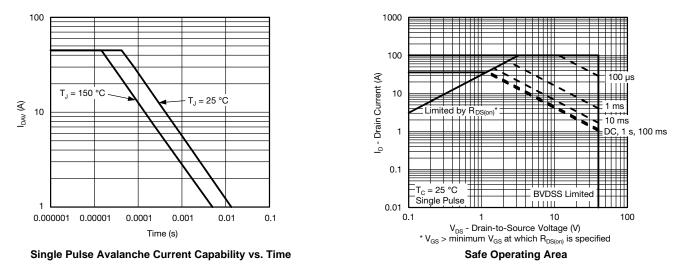
Threshold Voltage



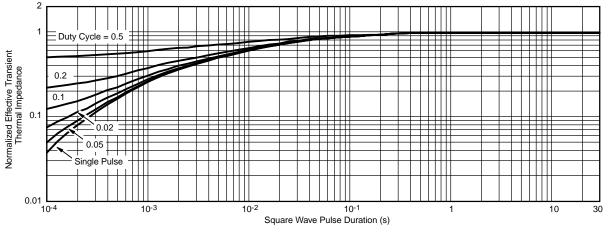
Drain Source Breakdown vs. Junction Temperature







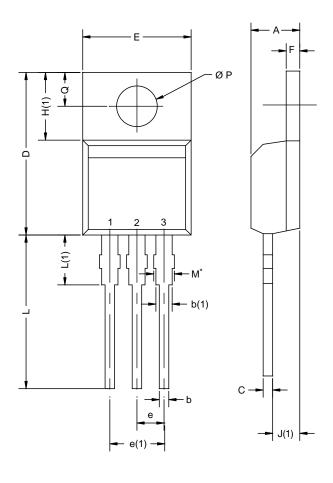
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case



# **TO-220AB**



|      | MILLIMETERS |       | INCHES |       |  |
|------|-------------|-------|--------|-------|--|
| DIM. | MIN.        | MAX.  | MIN.   | MAX.  |  |
| А    | 4.25        | 4.65  | 0.167  | 0.183 |  |
| b    | 0.69        | 1.01  | 0.027  | 0.040 |  |
| b(1) | 1.20        | 1.73  | 0.047  | 0.068 |  |
| С    | 0.36        | 0.61  | 0.014  | 0.024 |  |
| D    | 14.85       | 15.49 | 0.585  | 0.610 |  |
| Е    | 10.04       | 10.51 | 0.395  | 0.414 |  |
| е    | 2.41        | 2.67  | 0.095  | 0.105 |  |
| e(1) | 4.88        | 5.28  | 0.192  | 0.208 |  |
| F    | 1.14        | 1.40  | 0.045  | 0.055 |  |
| H(1) | 6.09        | 6.48  | 0.240  | 0.255 |  |
| J(1) | 2.41        | 2.92  | 0.095  | 0.115 |  |
| L    | 13.35       | 14.02 | 0.526  | 0.552 |  |
| L(1) | 3.32        | 3.82  | 0.131  | 0.150 |  |
| ØР   | 3.54        | 3.94  | 0.139  | 0.155 |  |
| Q    | 2.60        | 3.00  | 0.102  | 0.118 |  |

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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